

MH259 Hall-effect sensor is a temperature stable, stress-resistant switch. Superior high-temperature performance is made possible through a dynamic offset cancellation that utilizes chopper-stabilization. This method reduces the offset voltage normally caused by device over molding, temperature dependencies, and thermal stress.

MH259 includes the following on a single silicon chip: voltage regulator, Hall voltage generator, small-signal amplifier, chopper stabilization, Schmitt trigger, open-drain output. Advanced CMOS wafer fabrication processing is used to take advantage of low-voltage requirements, component matching, very low input-offset errors, and small component geometries.

MH259 is rated for operation between the ambient temperatures –40°C and +85°C for the E temperature range. The four package styles available provide magnetically optimized solutions for most applications. Package types SO is an SOT-23(1.1 mm nominal height), SP is an PSOT-23(0.55 mm nominal height),ST is an SOT-23(0.7mm nominal height), a miniature low-profile surface-mount package, while package UA is a three-lead ultra mini SIP for through-hole mounting.

The package type is in a Halogen Free version was verified by third party Lab.

Features and Benefits

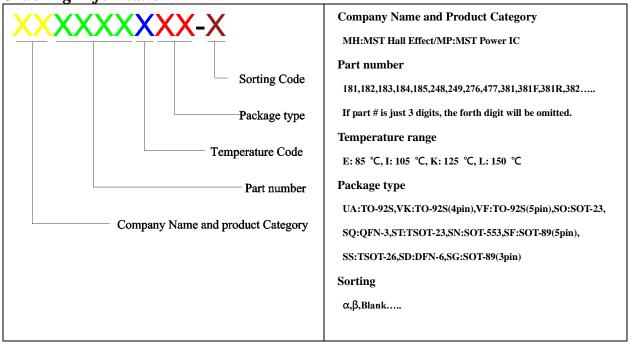
- CMOS Hall IC Technology
- Strong RF noise protection
- 2.5 to 6.0V for battery-powered applications
- Omni polar, output switches with absolute value of North or South pole from magnet
- Operation down to 2.5V, Micro power consumption
- High Sensitivity for reed switch replacement applications
- Multi Small Size option
- Low sensitivity drift in crossing of Temp range
- Ultra Low power consumption at 350uA (Avg)
- High ESD Protection, HBM $> \pm 4$ KV(min)
- Open Drain output
- RoHS compliant 2011/65/EU and Halogen Free

Applications

- Solid state switch
- Lid close sensor for battery powered devices
- Magnet proximity sensor for reed switch replacement in low duty cycle applications
- Water Meter
- Floating Meter



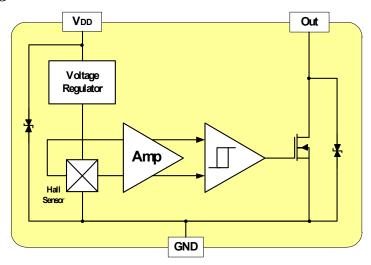
Ordering Information



| Part No. | Temperature Suffix | Package Type | |
|----------|--|--------------|--|
| MH259KUA | $K (-40^{\circ}C \text{ to} + 125^{\circ}C)$ | UA (TO-92S) | |
| MH259EUA | $E (-40^{\circ}C \text{ to } + 85^{\circ}C)$ | UA (TO-92S) | |
| MH259ESO | $E (-40^{\circ}C \text{ to } + 85^{\circ}C)$ | SO (SOT-23) | |

Custom sensitivity selection is available by MST sorting technology

Functional Diagram



Note: Static sensitive device; please observe ESD precautions. Reverse V_{DD} protection is not included. For reverse voltage protection, a 100Ω resistor in series with V_{DD} is recommended.



Absolute Maximum Ratings At (Ta=25°C)

| Characteristics | | | Values | Unit | |
|--|----------------------------------|-------------|-------------|-------|--|
| Supply voltage,(VDD) | | | 6.5 | V | |
| Output Voltage,(Vout) | | | 6.5 | V | |
| Reverse voltage, (VDD) (VOUT) | | | -0.3 | V | |
| Magnetic flux density | | | Unlimited | Gauss | |
| Output current,(Iour) | | | 10 | mA | |
| On antino Tonno antono Poro | (T.) | "E" version | -40 to +85 | °C | |
| Operating Temperature Range, (Ta) | | "K" version | -40 to +125 | °C | |
| Storage temperature range, (<i>Ts</i>) | | | -55 to +150 | °C | |
| Maximum Junction Temp,(<i>Tj</i>) | | | 150 | °C | |
| Thermal Resistance | $(heta_{\scriptscriptstyle JA}$ | u) UA/SO | 206 / 543 | °C/W | |
| | (θ _{sc}) UA / SO | | 148 / 410 | °C/W | |
| Package Power Dissipation, (P_D) UA / SO | | | 606 / 230 | mW | |

Note: Exceeding the absolute maximum ratings may cause permanent damage. Exposure to absolute maximum-rated conditions for extended periods may affect device reliability.

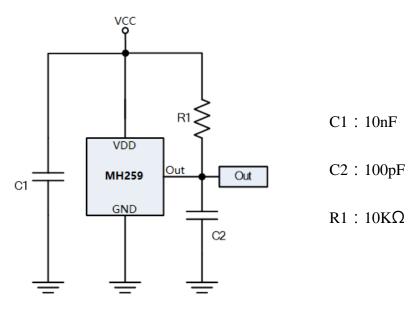
Electrical Specifications

DC Operating Parameters T_A=+25°C, V_{DD}=3.0V

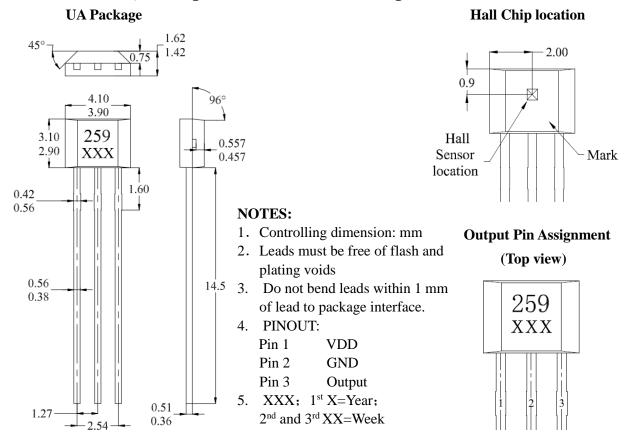
| Parameters Parameters Parameters | | Test Conditions | Min | Тур | Max | Units |
|----------------------------------|------|--|-----|-----|------|-------|
| Supply Voltage,(VDD) | | Operating | 2.5 | | 6 | V |
| Supply Current,(IDD) | | Awake State | | 1.5 | 3.0 | mA |
| | | Sleep State | | 3.5 | 7.0 | uA |
| | | Average | | 350 | 600 | uA |
| Output Saturation Voltage, | | Iout=5mA,B>BOP | | | 200 | mV |
| Output Leakage Current,(Ioff) | | IOFF B <brp, vout="5.5V</td"><td></td><td></td><td>1.0</td><td>uA</td></brp,> | | | 1.0 | uA |
| Awake mode time,(<i>Taw</i>) | | Operating | | 40 | 80 | uS |
| Sleep mode time,(TSL) | | Operating | | 160 | 320 | uS |
| Duty Cycle,(D,C) | | | | 25 | | % |
| Response Time,(TRES) | | | | | 2000 | Hz |
| Electro-Static Discharge | | НВМ | 4 | | | KV |
| Operating Point | BOPS | S pole to branded side, B > BOP, Vout | 20 | | 55 | Gauss |
| | BOPN | N pole to branded side, B > BOP, Vout | -55 | | -20 | Gauss |
| Release Point | BRPS | S pole to branded side, B < BRP, Vout | 10 | | 45 | Gauss |
| | BRPN | N pole to branded side, B < BRP, Vout | -45 | | -10 | Gauss |
| Hysteresis | BHYS | BOPx - BRPx | | 10 | | Gauss |



Typical Application circuit



Sensor Location, Package Dimension and Marking

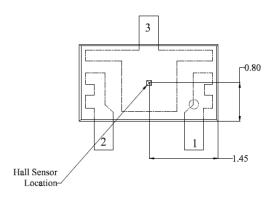




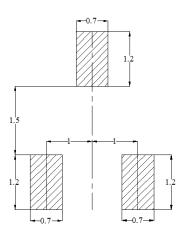
SO Package (Top View)

3.00 2.80 0.50 0.30 3 0.55 0.35 259XX 3.00 2.60 1.70 1.50 0.436 0.434 1 2 -1.90-0.00 1.25 0.90

Hall Plate Chip Location (Bottom view)



(For reference only)Land Pattern



NOTES:

- 1. PINOUT (See Top View at left :)
 Pin 1 V_{DD}; Pin 2 Output; Pin 3 GND
- 2. Controlling dimension: mm
- 3. Lead thickness after solder plating will be 0.254mm maximum
- 4. XX: Date Code, Refer to DC table